UNISONIC TECHNOLOGIES CO., LTD

UCD4014B Preliminary *CMOS IC*

CMOS 8-STAGE STATIC SHIFT REGISTERS

SOP-16

TSSOP-16

■ DESCRIPTION

The **UTC UCD4014B is** a 8-stage synchronous parallel or serial input/serial output registers having common CLOCK and PARALLEL/SERIAL CONTROL inputs, a SERIAL data input, and individual parallel inputs to each register stage. Each register is a D-type master-slave flip-flop. Q6, Q7, and Q8 are outputs. With the positive clock line transition in the **UCD4014B** parallel/serial entry is made into the register synchronously.

In **UCD4014B** serial entry is controlled by the PARALLEL/SERIAL CONTROL input. When the PARALLEL/SERIAL CONTROL input is low, data is serially shifted into the 8-stage register synchronously with the positive transition of the clock line. When the PARALLEL/SERIAL CONTROL input is high, data is jammed into the 8-stage register via the parallel input lines and synchronous with the positive transition of the clock line.

■ FEATURES

* Up to 20V operation voltage
* 12MHz (typ.) clock rate at 10V
* Maximum input current of 1μA at 18V
* Fully static operation
* 8 master-slave flip-flops plus output buffering and control gating

■ APPLICATIONS

* General-purpose register
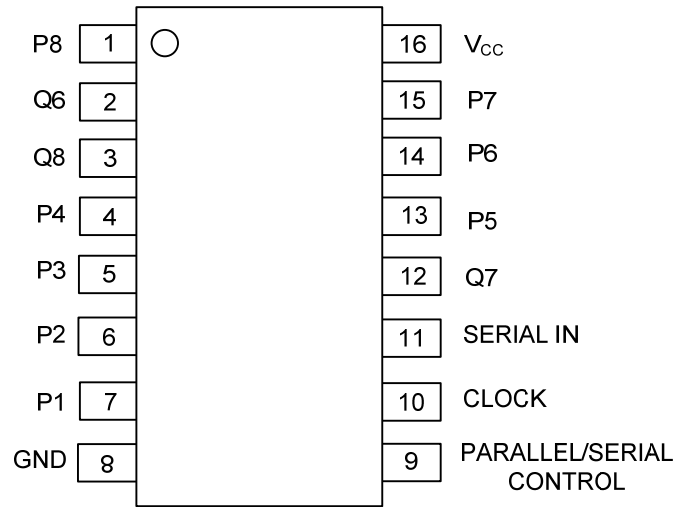* Parallel input/serial output data queueing
* Parallel to serial data conversion

■ ORDERING INFORMATION

Ordering Number		Package	Packing
Lead Free	Halogen Free		
UCD4014BL-S16-R	UCD4014BG-S16-R	SOP-16	Tape Reel
UCD4014BL-S16-T	UCD4014BG-S16-T	SOP-16	Tube
UCD4014BL-P16-R	UCD4014BG-P16-R	TSSOP-16	Tape Reel
UCD4014BL-P16-T	UCD4014BG-P16-T	TSSOP-16	Tube
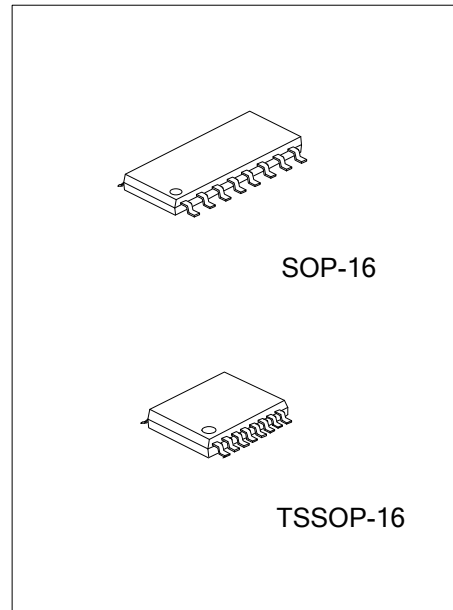
UCD4014BL-S16-R

(1)Packing Type

(2)Package Type

(3)Lead Free

(1) T: Tube, R: Tape Reel

(2) S16: SOP-16, P16: TSSOP-16

(3) L: Lead Free, G: Halogen Free

QW-R502-606.c

UCD4014B

■ **PIN CONFIGURATION**

P8	1		16	V_{CC}
Q6	2		15	P7
Q8	3		14	P6
P4	4		13	P5
P3	5		12	Q7
P2	6		11	SERIAL IN
P1	7		10	CLOCK
GND	8		9	PARALLEL/SERIAL CONTROL
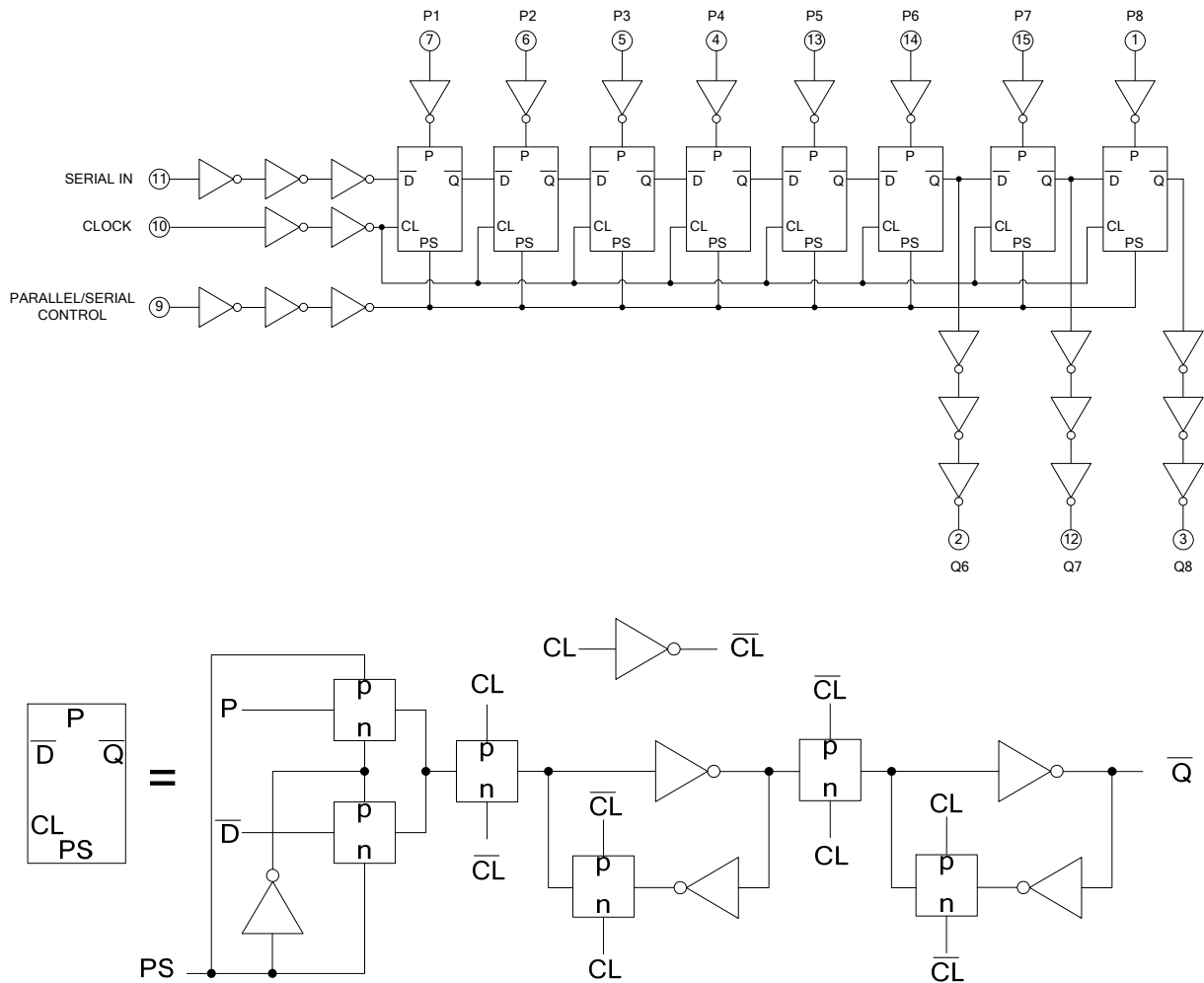
■ **LOGIC DIAGRAM**

Fig.1 logic diagram

UCD4014B

■ **TRUE TABLE**

CL	SER IN	PAR SER CONTROL	P_1	P_n	Q_1 (INTERNAL)	Q_n
⤒	X	1	0	0	0	0
⤒	X	1	1	0	1	0
⤒	X	1	0	1	0	1
⤒	X	1	1	1	1	1
⤒	0	0	X	X	0	Q_{n-1}
⤒	1	0	X	X	1	Q_{n-1}
⤓	X	X	X	X	Q_1 (NC)	Q_N (NC)

Note: X = Don't Care Case, NC = No Change

■ **ABSOLUTE MAXIMUM RATING** (T_A =25°C , unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Supply Voltage		V_{CC}	-0.5 ~ 20	V
Input Voltage		V_{IN}	-0.5 ~ V_{CC} + 0.5	V
Output Voltage		V_{OUT}	-0.5 ~ V_{CC} + 0.5	V
Input Clamp Current (V_{IN}<0, or V_{IN}>V_{CC})		I_{IK}	±10	mA
Power Dissipation	T_A=-55°C~+100°C	P_D	500	mW
	T_A=+100°C~+125°C		200	mW
Storage Temperature		T_{STG}	-65 ~ +150	°C

Note: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.
Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

■ **RECOMMENDED OPERATING COMDITIONS**

PARAMETER	SYMBOL	CONDITIONS	MIN	MAX	UNIT
Supply Voltage	V_{CC}		3	18	V
Clock Pulse Width	t_W	V_{CC} = 5V	180	-	ns
		V_{CC} = 10V	80	-	
		V_{CC} = 15V	50	-	
Clock Frequency	f_{CL}	V_{CC} = 5V	-	3	MHz
		V_{CC} = 10V	-	6	
		V_{CC} = 15V	-	8.5	
Clock Rise and Fall Time	t_r, t_f	V_{CC} = 5V	-	15	µs
		V_{CC} = 10V	-	15	
		V_{CC} = 15V	-	15	
Set-up Time, Serial Input		V_{CC} = 5V	120	-	ns
		V_{CC} = 10V	80	-	
		V_{CC} = 15V	60	-	
Set-up Time, Parallel Input	t_S	V_{CC} = 5V	80	-	ns
		V_{CC} = 10V	50	-	
		V_{CC} = 15V	40	-	
Set-up Time, Parallel/Serial Control		V_{CC} = 5V	180	-	ns
		V_{CC} = 10V	80	-	
		V_{CC} = 15V	60	-	

■ **ELECTRICAL CHARACTERISTICS** (T_A =25°C , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Quiescent Supply Current	I_{CC}	V_{IN}=0, 5V, V_{CC}=5V		0.04	5	µA
		V_{IN}=0, 10V, V_{CC}=10V		0.04	10	
		V_{IN}=0, 15V, V_{CC}=15V		0.04	20	
		V_{IN}=0, 20V, V_{CC}=20V		0.08	100	
Output Low (Sink) Current	I_{OL}	V_{OUT}=0.4V, V_{IN}=0,5V, V_{CC}=5V	0.51	1		mA
		V_{OUT}=0.5V, V_{IN}=0,10V, V_{CC}=10V	1.3	2.6		
		V_{OUT}=1.5V, V_{IN}=0,15V, V_{CC}=15V	3.4	6.8		
Output High (Source) Current	I_{OH}	V_{OUT}=4.6V, V_{IN}=0, 5V, V_{CC}=5V	-0.51	-1		mA
		V_{OUT}=2.5V, V_{IN}=0, 5V, V_{CC}=5V	-1.6	-3.2		
		V_{OUT}= 9.5V, V_{IN}=0,10V, V_{CC}=10V	-1.3	-2.6		
		V_{OUT}=13.5V, V_{IN}=0,15V, V_{CC}=15V	-3.4	-6.8		
Output Voltage: Low-Level	V_{OL}	V_{IN}=0,5V, V_{CC}=5V		0	0.05	V
		V_{IN}=0,10V, V_{CC}=10V		0	0.05	
		V_{IN}=0,15V, V_{CC}=15V		0	0.05	

■ **ELECTRICAL CHARACTERISTICS(Cont.)**

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output Voltage: High-Level	V_{OH}	V_{IN} = 0, 5V, V_{CC} = 5V	4.95	5		V
		V_{IN} = 0, 10V, V_{CC} = 10V	9.95	10		
		V_{IN} = 0, 15V, V_{CC} = 15V	14.95	15		
Input Low Voltage	V_{IL}	V_{OUT} = 0.5, 4.5V, V_{CC} = 5V			1.5	V
		V_{OUT} = 1, 9V, V_{CC} = 10V			3	
		V_{OUT} = 1.5, 13.5V, V_{CC} = 15V			4	
Input High Voltage	V_{IH}	V_{OUT} = 0.5, 4.5V, V_{CC} = 5V	3.5			V
		V_{OUT} = 1, 9V, V_{CC} = 10V	7			
		V_{OUT} = 1.5, 13.5V, V_{CC} = 15V	11			
Input Leakage Current	$I_{I(LEAK)}$	V_{IN} = 0, 18 V, V_{CC} = 18V		$\pm 10^{-5}$	± 0.1	μA

■ **SWITCHING CHARACTERISTICS** (T_A =25°C, Input t_r, t_f =20ns, C_L =50Pf, R_L = 200KΩ)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Propagation Delay Time	t_{PLH} / t_{PHL}	V_{CC}=5V		160	320	ns
		V_{CC}=10V		80	160	
		V_{CC}=15V		60	120	
Transition Time	t_{THL}/ t_{TLH}	V_{CC}=5V		100	200	ns
		V_{CC}=10V		50	100	
		V_{CC}=15V		40	80	
Maximum Clock Input Frequency	f_{CL}	V_{CC}=5V	3	6		MHz
		V_{CC}=10V	6	12		
		V_{CC}=15V	8.5	17		
Minimum Clock Pulse Width	t_W	V_{CC}=5V		90	180	ns
		V_{CC}=10V		40	80	
		V_{CC}=15		25	50	
Clock Rise and Fall Time	t_r / t_f	V_{CC}=5V			15	μs
		V_{CC}=10V			15	
		V_{CC}=15V			15	
Minimum Setup Time, Serial Inputs	t_S	V_{CC}=5V		60	120	ns
		V_{CC}=10V		40	80	
		V_{CC}=15V		30	60	
Minimum Setup Time, Parallel Inputs	t_S	V_{CC}=5V		40	80	ns
		V_{CC}=10V		25	50	
		V_{CC}=15V		20	40	
Minimum Hold Time, Serial In, Parallel In, Parallel/Serial Control	t_H	V_{CC}=5V			0	ns
		V_{CC}=10V			0	
		V_{CC}=15V			0	
Average Input Capacitance	C_I	Any Input		5	7.5	pF

■ **TEST CIRCUITS AND WAVEFORMS**
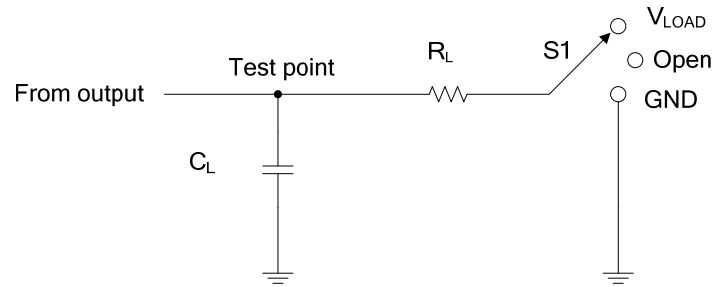
Fig 1. Test Circuit

Test	S1
t_{PLH}/t_{PHL}	GND

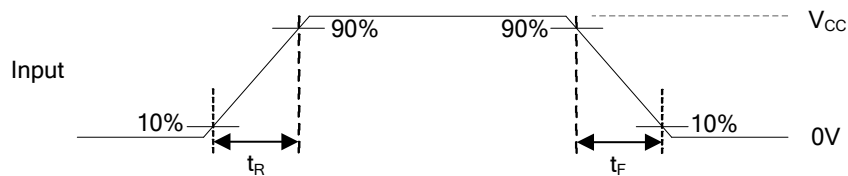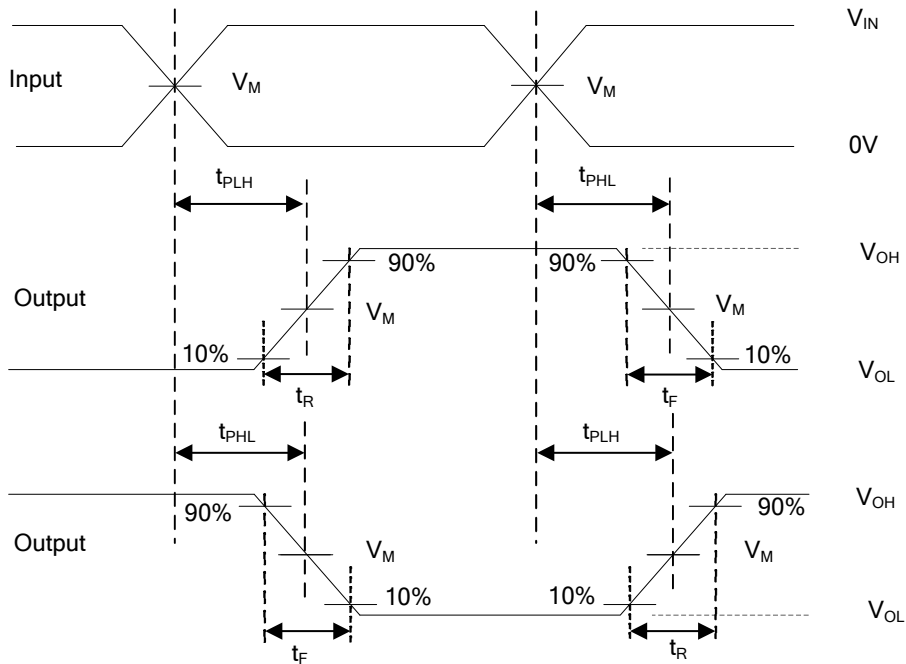| Inputs		V_M	V_{LOAD}	C_L	R_L
V_{IN}	t_r, t_f				
V_{CC}	20 ns	$V_{CC}/2$	V_{CC}	50 pF	200 KΩ

Fig 2. Voltage Waveforms Input Rise and Fall Times

Fig 3. Voltage Waveforms Propagation Delay and Output Transition Times

Notes: 1. C_L includes probe and jig capacitance.
　　　　2. All input pulses are supplied by generators having the following characteristics: PRR ≤1MHz, Z_O = 50Ω.

■ **TEST CIRCUITS AND WAVEFORMS(Cont.)**
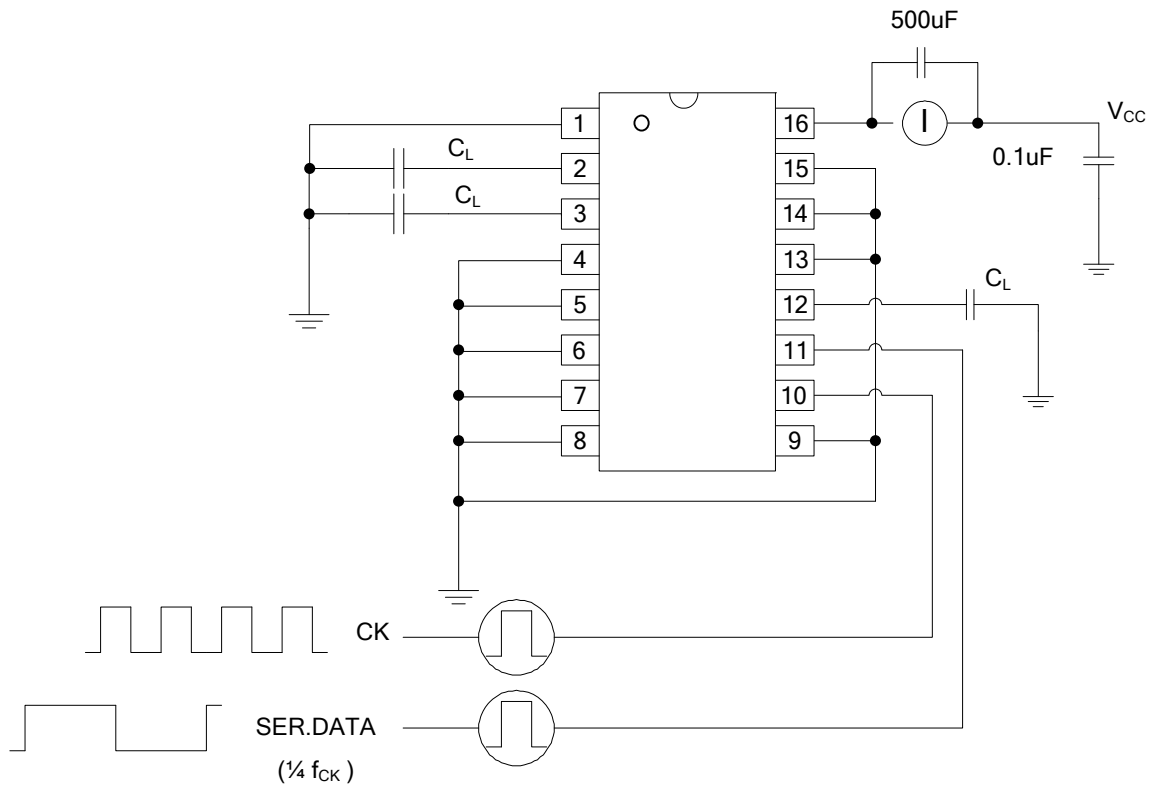
Fig 4. Dynamic power dissipation test circuit
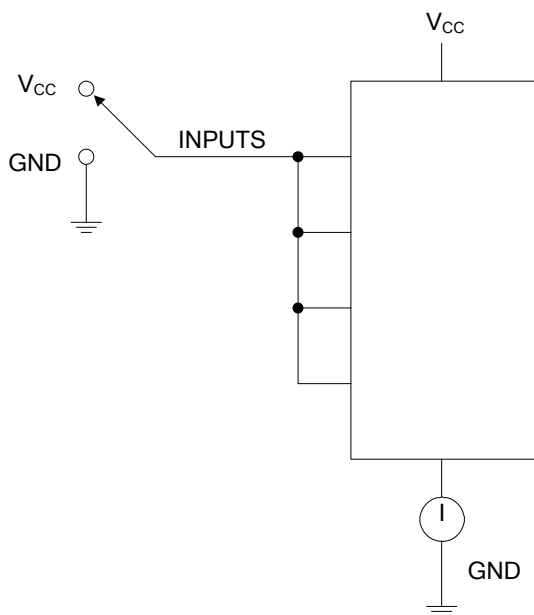
Fig 5. Quiescent device current test circuit

■ **TEST CIRCUITS AND WAVEFORMS(Cont.)**
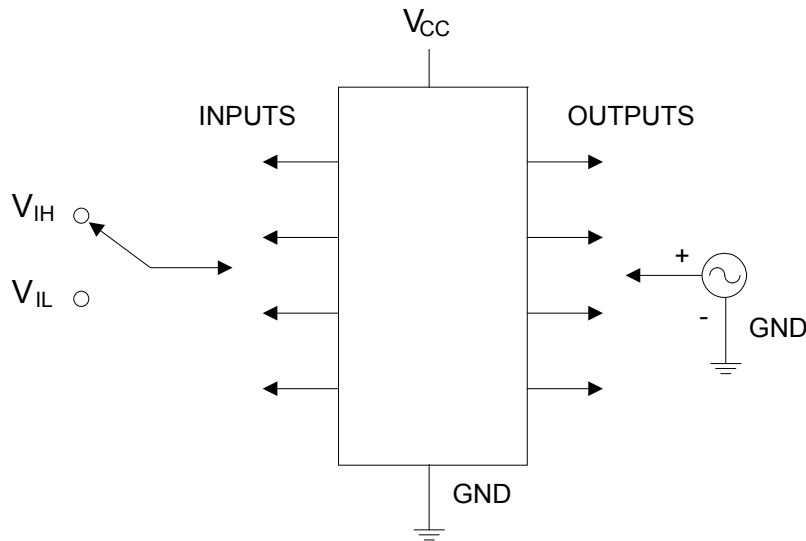
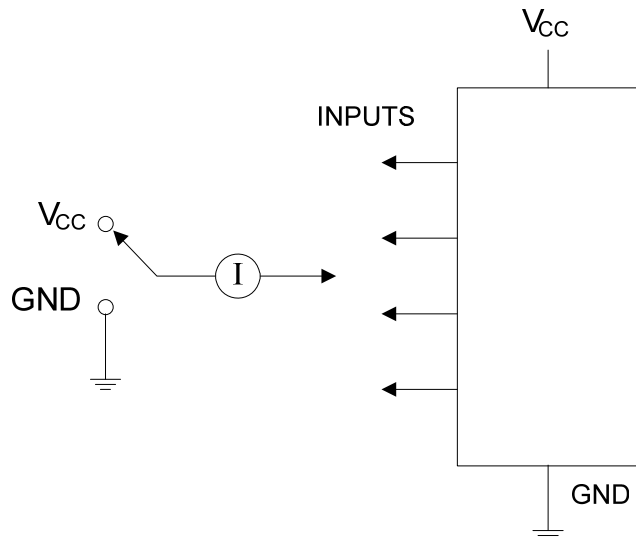
Fig 6. Input voltage test circuit

Fig 7. Input current test circuit

Note：measure inputs sequentially, to both V_{CC} and GND; connect all unused inputs to either V_{CC} or GND.